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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO. CONFIRMATION NO.	
10/533,570	06/27/2005	Simon Charles Page	42981.00009 1806	
32294 SOUIRE SAN	7590 08/08/200 DERS & DEMPSEY L	EXAMINER		
14TH FLOOR		SOUW, BERNARD E		
8000 TOWERS CRESCENT TYSONS CORNER, VA 22182			ART UNIT	PAPER NUMBER
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Please find below and/or attached an Office communication concerning this application or proceeding.

The time period for reply, if any, is set in the attached communication.

		Application	n No.	Applicant(s)		
		10/533,57	0	PAGE ET AL.		
	Office Action Summary	Examiner		Art Unit		
		Bernard E.	Souw	2881		
Period for	- The MAILING DATE of this communica r Reply	tion appears on the	cover sheet with the c	orrespondence addr	ess	
A SHO WHIC - Exten- after S - If NO - Failur Any re	DRTENED STATUTORY PERIOD FOR HEVER IS LONGER, FROM THE MAIL sions of time may be available under the provisions of 3 SIX (6) MONTHS from the mailing date of this communic period for reply is specified above, the maximum statute to reply within the set or extended period for reply will, apply received by the Office later than three months after d patent term adjustment. See 37 CFR 1.704(b).	LING DATE OF TH 7 CFR 1.136(a). In no ever action. In period will apply and will by statute, cause the appli	IIS COMMUNICATION ont, however, may a reply be tim disprise SIX (6) MONTHS from ication to become ABANDONE	N. nely filed the mailing date of this comi D (35 U.S.C. § 133).	,	
Status						
2a) <u></u> 3) <u></u>	Responsive to communication(s) filed of This action is FINAL . 2b) Since this application is in condition for closed in accordance with the practice	☑ This action is no allowance except	on-final. for formal matters, pro		nerits is	
Disposition	on of Claims					
5) [Claim(s) <u>1-26</u> is/are pending in the app la) Of the above claim(s) is/are version is/are version is/are allowed. Claim(s) <u>1-26</u> is/are rejected. Claim(s) is/are objected to. Claim(s) are subject to restriction	withdrawn from cor				
Application	on Papers					
10)⊠ 1	The specification is objected to by the E The drawing(s) filed on <u>03 May 2005</u> is/ Applicant may not request that any objectio Replacement drawing sheet(s) including the The oath or declaration is objected to by	are: a) \boxtimes accepted in to the drawing(s) be correction is require	e held in abeyance. See ed if the drawing(s) is obj	e 37 CFR 1.85(a). jected to. See 37 CFR		
Priority u	nder 35 U.S.C. § 119					
 12) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f). a) All b) Some * c) None of: 1. Certified copies of the priority documents have been received. 2. Certified copies of the priority documents have been received in Application No. 3. Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)). * See the attached detailed Office action for a list of the certified copies not received. 						
2) Notice	(s) e of References Cited (PTO-892) e of Draftsperson's Patent Drawing Review (PTO- nation Disclosure Statement(s) (PTO/SB/08)	-948)	4) Interview Summary Paper No(s)/Mail Da 5) Notice of Informal P	ate		
	No(s)/Mail Date <u>05/03/2005</u> .		6) Other:			

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DETAILED ACTION

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Priority

1. Receipt is acknowledged of papers submitted under 35 U.S.C. 119(a)-(d), GB-0225791.3, filed on 11/05/2002 in Great Britain, which papers have been placed of record in the file.

2. Receipt is acknowledged of papers submitted under 35 U.S.C. 371 (PCT/GB2003/004750) which papers have been placed of record in the file.

Information Disclosure Statement

3. Receipt is acknowledged of information disclosure statement (IDS) submitted on 005/03/2005. The submission is in compliance with the provisions of 37 CFR 1.97.

A signed copy of the information disclosure statement is here enclosed.

Preliminary Amendment

4. The Preliminary Amendment filed on 05/03/2005 has been entered. The present Office Action is made with all the suggested amendments being fully considered.

Claims 1-26 are pending in this Office Action.

Claim Rejections - 35 USC § 102

The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

(b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.

5. Claims 1, 2, 14, 15 and 26 are rejected under 35 U.S.C. 102(b) as being anticipated by Larson et al. (USPAT 5,444,242), hereinafter Larson'242.

Larson'242 discloses in Fig.6 a photoelectron spectrometer 56' (in replacement of 56 shown in Fig.1) which is operable in a first mode to produce a photoelectron energy spectrum relating to the composition of a sample being analyzed, and in a second mode to produce a photoelectron image of the surface of the sample 12 being analyzed, as recited in Col.9/II.58-68 and Col.10/II.1-38, especially in Col.10/II.13-28, wherein the energy analyzer mode is expressly recited in Col.10/II.19-22 and the imaging mode in Col.10/II.16-19, wherein the spectrometer includes a detector (SED) which is used to detect photoelectrons produced in both modes of operation, as recited in Col.12/II.31-33 in view of Col.9/II.41-53. Note the inverted definition of 1st and 2nd modes of operation: Larson'242's 1st mode is for imaging, as recited in Col. 10/II.16-19 and Col.11/II.29-31, whereas Larson'242's 2nd mode is for energy analysis, as recited in Col. 10/II.19-22 and Col.11/II.15-16.

Specifically regarding claim 26, Larson'242's method includes a step of selecting which of the 1st and 2nd modes is to use and the detector being operated accordingly, as

recited in Col.10/II.22-28 and Col.11/II.15-41, more specifically in claim 11, Col.16/II.29-36.

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6. Claims 1-2, 14-15 and 26 are also rejected under 35 U.S.C. 102(b) as being anticipated by Coxon et al. (USPAT 6,104,029), hereinafter Coxon'029.

Coxon'029 discloses in Fig.1 a charged particle spectrometer (hemispherical photoelectron energy analyzer 5), as recited in Col.6/II.56-67 & Col.7/II.1-53, the spectrometer being operable in a first mode to produce an energy spectrum relating to the composition of a sample being analyzed (i.e., in the energy-dispersive radial direction of slit 61), as recited in Col.9/II.18-23, and in a second mode to produce a charged particle image of the surface 15 of the sample 17 being analyzed, as recited in Col.9/II.27-47, especially in Col.9/II.37-40. As well known in the art, a real image is formed on the image plane of a lens, whereas a diffraction image is formed on the focal plane of the same lens, as inclusively manifested in Col.9/II.18-47 and Col.10/II.37-54. The diffraction image recited in Col.7/II.2-3 is irrelevant for the rejection. Therefore, recording of the diffraction image is simply discarded/omitted.

Specifically regarding claim 26, a selection between a real image of the sample surface 17 (or 15) and a photoelectron energy spectrum revealing the identity of the chemical elements at a particular point on the sample surface is recited in Col.9/II.18-47 and Col.10/II.37-54, especially lines 45-51.

Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

- (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 7. This application currently names joint inventors. In considering patentability of the claims under 35 U.S.C. 103(a), the examiner presumes that the subject matter of the various claims was commonly owned at the time any inventions covered therein were made absent any evidence to the contrary. Applicant is advised of the obligation under 37 CFR 1.56 to point out the inventor and invention dates of each claim that was not commonly owned at the time a later invention was made in order for the examiner to consider the applicability of 35 U.S.C. 103(c) and potential 35 U.S.C. 102(e), (f) or (g) prior art under 35 U.S.C. 103(a).
- 8. Claims 3, 4, 16 and 17 are rejected under 35 U.S.C. 103(a) as being unpatentable over Coxon'029 in view of Faris et al. (USPAT 5,265,327).

Coxon'029's detector 65 shown in Fig.1 is a two-dimensional position detector 65, as recited in Col.7/II.48-53. Such a two-dimensional position detector is known in the art as to also include microchannel plates (MCP). As known in the art, a microchannel plate is a plate (means), which emits a plurality of secondary electrons for each primary electron received, thus covering the limitation of claims 3 and 16.

This Official Notice is supported by Faris et al., as recited in Col.1/II.10-58. As is obvious in Figs.3, 4, 6 10 and 12, the MCP has the form of a plate.

It would have been obvious to one of ordinary skill in the art at the time the invention was made to use Faris's MCP as Coxon'029's two-dimensional position detector photoelectron detector capable of recording both the photoelectron energy spectrum and the photoelectron image of the sample surface, since a spatial resolution is needed for both functions.

One of ordinary skill in the art would have been motivated to use a detector having two-dimensional position or spatial resolution, since in both functions the photoelectrons are emitted in an extended spatial extent, i.e., a dispersion according to electron energies and a spatial distribution according to sample surface.

9. Claims 5-12 and 18-24 are rejected under 35 U.S.C. 103(a) as being unpatentable over Coxon'029 in view of Faris et al., and further in view of Wollnik et al. (USPAT 5,644,128).

Coxon'029 as modified by Faris et al. disclose all the limitations of claims 5-7 and 18-20, as previously applied to the parent claims 3 and 16, respectively, except the additional limitation that the two-dimensional position-sensitive detector also includes a first delay line means for using the plurality of secondary electrons to produce a pair of electrical pulses in a first delay line from which a signal processing means can calculate the location of the primary electron on the plate means in a first direction (claims 5 and 18); a second delay line means for using the plurality of secondary electrons to produce

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a pair of electrical pulses in a second delay line from which the signal processing means can calculate the location of the primary electron on the plate means in a second direction (claims 6 and 19); wherein the first and second directions are orthogonal (claims 7 and 20).

Using delay lines to read out MCP signal is conventional in the art. Wollnik et al. disclose a two-dimensional position-sensitive detector in the form of channel plate(s) (11a,b shown in Fig.1) that amplifies the detected particles into an electron cloud upon impact with the channel plates, which exactly match the description and function of an MCP as used in parent claim 5 and 18, including the recitation that the rear surface of the channel plates may comprise a plane at fixed or ground potential, all recited by Wollnik et al. in Col.1/II.56-64 and Col.5/II.15-21.

Wollnik's two-dimensional position-sensitive detector 11a,b also includes a first delay line 13 (shown in Fig.3A,B and Fig.4B) for using the plurality of secondary electrons to produce a pair of electrical pulses in a first delay line (between 13a and 13b) from which a signal processing means can calculate the location of the primary electron on the plate 11a,b in a first direction, as recited in Col.5/II.22-36; and a second delay line 39 (shown in Fig.4A) for using the plurality of secondary electrons to produce a pair of electrical pulses in a second delay line (between 39a and 39b) from which the signal processing means can calculate the location of the primary electron on the plate 11a,b in a second direction, as recited in Col.6/II.8-15; wherein the first and second directions are orthogonal (addressed a x-meander and y-meander), as expressly recited in Col.6/II.16-19 and claimed in Col.8/II.60-62 (claim 14)...

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It would have been obvious to one of ordinary skill in the art at the time the

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invention was made to equip Coxon'029/Faris's two-dimensional multichannel detector

with Wollnik's readout technique based on delay lines, in order to enhance the dynamic

range and increase the timing accuracy, as taught by Wollnik et al. in Col.1/II.25-27.

One of ordinary skill in the art would have been motivated to enhance the

dynamic range and increase the timing accuracy, in order to be able to record the

highest count rates and thus maximize the detector capability.

10. Regarding claims 8 and 21, a second signal processing means does not need

special design or device feature, as is obvious from the disclosure pg.6/II.5-12, or

PGPub 2006/0060770, sect.[0015]. Therefore, the limitation of claims 8 and 21 is

equivalent to duplication of parts and/or repeat of process step to enhance

measurement accuracy without producing any unexpected result.

11. Claim 9 recites the same limitation as claim 26, which has been previously

rejected over Coxon'029. Therefore, claim 9 is also rejected over the same prior art

(Coxon'029), but now with Faris et al., and Wollnik et al. as additional prior art due to its

dependency on claim 5.

12. Regarding claims 10 and 22, Applicant's first mode is the same as Coxon'029's

second mode, i.e., photoelectron energy analysis. In this mode the detected signal

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distribution is one-dimensional (i.e., in the energy-dispersive radial direction of slit 61), as recited in Col.9/II.18-23.

It would have been obvious to one of ordinary skill in the art at the time the invention was made to process such a one-dimensional signal distribution by utilizing only one of Wollnik's 2-dimensional delay line means, since the other delay line means is not needed.

One of ordinary skill in the art would have been motivated to utilize only one of Wollnik's 2-dimensional delay line means, in order to save effort, time and energy.

13. Regarding claims 11 and 23, Applicant's second mode is the same as Coxon'029's first mode, i.e., photoelectron image. In this mode the detected signal distribution is two-dimensional (i.e., image of the surface 15 of the sample 17, as recited in Col.9/II.27-47, especially in Col.9/II.37-40).

It would have been obvious to one of ordinary skill in the art at the time the invention was made to process such a two-dimensional signal distribution by utilizing both of Wollnik's 2-dimensional delay line means, since both delay line means are now needed.

One of ordinary skill in the art would have been motivated to utilize both of Wollnik's 2-dimensional delay line means, in order to process a two-dimensional image.

14. Regarding claims 12 and 24, increasing the accuracy of time measurements of the electrical pulses is taught by Wollnik et al. in Col.1/II.25-32.

15. Claims 13 and 25 are rejected under 35 U.S.C. 103(a) as being unpatentable over Coxon'029 in view of Faris et al., and Wollnik et al., and further in view of Abshire (USPAT 5,566,139).

Coxon'029 as modified by Faris et al. and Wollnik et al. disclose all the limitations of claims 13 and 25, as previously applied to their respective parent claims 12 and 24, except the recitation of increasing the accuracy by stretching the time between each one of a pair of pulses so that the time difference may be more accurately measured.

Increasing the accuracy of event or sampling time measurements by time-stretching technique is well known in the art. Abshire discloses a sampling time interval unit having picosecond accuracy using a time stretching technique, the basics of which is recited in Col.3/II.43-67 and Col.4/II.1-34.

It would have been obvious to one of ordinary skill in the art at the time the invention was made to use a time stretching technique to improve the timing accuracy of Wollnik's pulse arrival events, in order to improve the energy resolution of the photoelectron spectrum measured as well as the spatial resolution of the sample surface image.

One of ordinary skill in the art would have been motivated to enhance the resolution in Coxon'029's measurement by improving the timing accuracy of Wollnik's pulse arrival events, since the latter is directly related to spatial and energy resolutions through the delay line technique.

Communications

16. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Bernard E Souw, Ph.D., whose telephone number is 571 272 2482. The examiner can normally be reached on Monday thru Friday, 9:00 am to 5:00 pm..

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Robert Kim can be reached on 571 272 2293. The central fax phone number for the organization where this application or proceeding is assigned is 571 273 8300 for regular communications as well as for After Final communications.

Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the receptionist whose telephone number is 571 272 5993.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Bernard E. Souw, Ph.D.

Patent Examiner – AU 2881

August 03, 2007